

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor dates sheds, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor dates sheds and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use on similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor and its officers, employees, subsidiaries, affliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out or i, directly or indirectly, any lange of the applicatio customer's to unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the

AN-5026

Fairchild Semiconductor Application Note January 2001 Revised September 2001



AN-5026 Using BGA Packages

SEMICONDUCTOR

Using BGA Packages

Introduction

Demanding space and weight requirements of personal computing and portable electronic equipment has led to many innovations in IC packaging. Combining the right interface and logic products with new package technology can have a significant impact on the capabilities and form-factor of the end product. Leaded surface mount devices are constantly pushing the manufacturing capabilities of leading board manufacturers to finer and finer lead pitch geometry's to increase I/O density and reduce board space.

This requirement has lead to significant interest in the JEDEC (Joint Electron Device Engineering Council) registered Fine-Pitch Ball Grid Array (FBGA) package. These packages are ideally suited to low cost, high volume applications, where package size and performance is of major importance. Typical BGA applications include:

- 1. Notebook computers
- 2. Personal Digital Assistants (PDA's)
- 3. Mobile telephone handsets
- 4. High density disk drives
- 5. Camcorders
- 6. Digital cameras

BGA advantages compared to fine pitch QFP or TSSOP packages:

- 1. BGAs are usually smaller.
- 2. BGAs have larger pitch.
- 3. BGAs have no fragile leads, that causes yield and rework problems.
- 4. Board assembly yields are significantly improved.
- 5. Board inspection can be reduced.
- 6. BGAs have better thermal and electrical properties.
- 7. In many applications, the use of BGA results in significant system level cost savings.

Surface Mount vs. BGA

At 0.4 to 0.5mm pin pitch, the race to finer surface mount lead pitches has hit several technical and economic walls. Manufacturing anything smaller will significantly impact PCB yield and push board costs above acceptable levels for the highly competitive and cost conscious electronics industry. Avoiding problems such as bent leads and solder bridging become significant manufacturing challenges. Additionally, electrical problems such as crosstalk become a major issue due to the length and close pitch of the leads on surface mount packages.

Alternatively, BGA packaging uses relatively wide "pad to pad" pitch rules and when coupled with existing PCB manufacturing processes result in high yields. The "array" approach improves I/O density and reduces the board space consumed by the device. Table 1 and Figure 1 show examples of space savings of BGA over surface mount packages.

TABLE 1. BGA Space Savings Compared to Surface Mount Packages

Number of Bits	TSSOP	TVSOP	QVSOP BQSOP
36 to 48	> 66%	> 47%	> 59%
32 to 40	> 67%	61%	49%
18 to 24	65.50%	40%	NA
16 to 20	61%	39%	37%

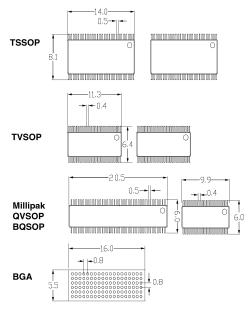
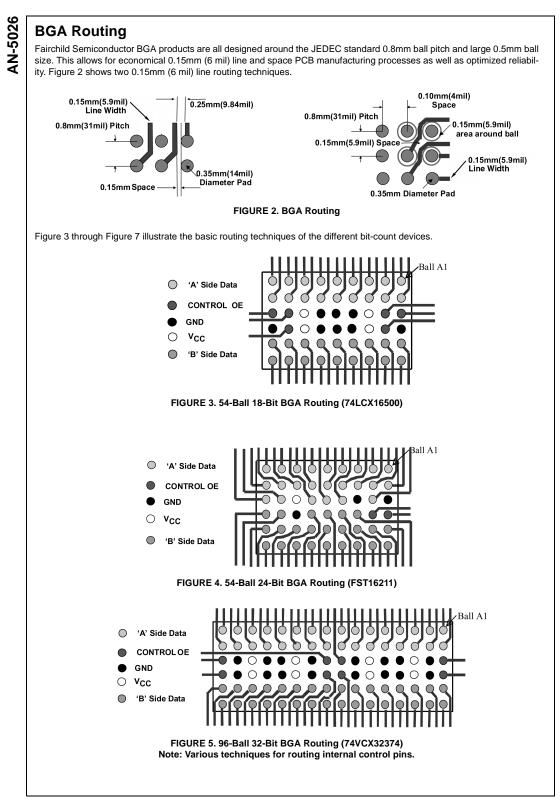
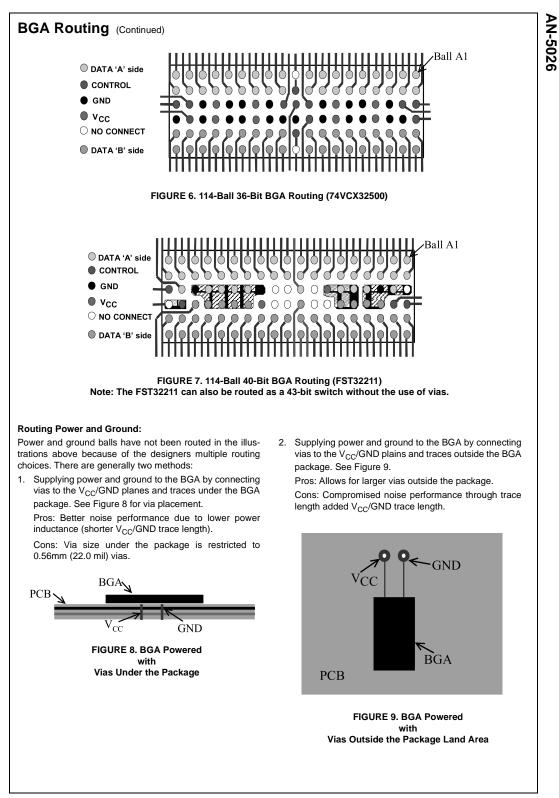


FIGURE 1. 114 Ball BGA vs. Surface Mount



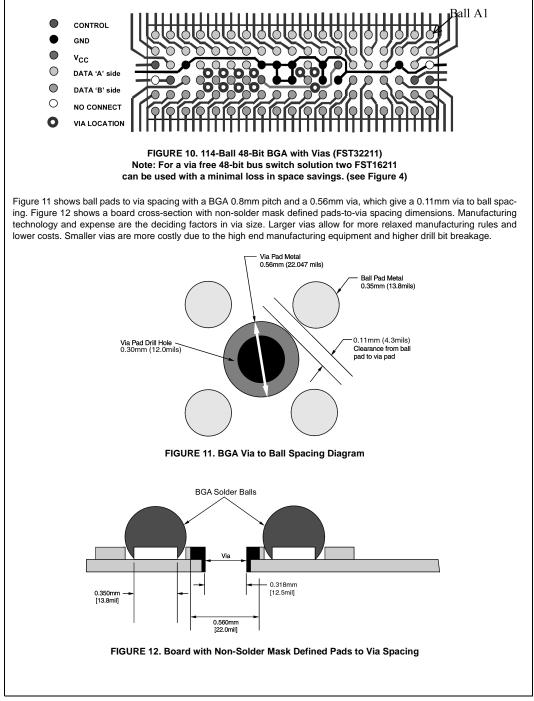
2





BGA Via Design and Layout Options

When using vias in high bit-count devices such as the 48-bit FST32211 (see Figure 10), via density and placement become critical issues for the layout designer. The use of through-board vias allows access to all signal bits on the device; this helps contribute to maximum space integration. Additionally, the board backside vias can be used to connect components such as termination and decoupling devices if needed.



BGA Via Design and Layout Options (Continued)

Through-board vias are the most economical via type from a board manufacturing perspective. However, trade-offs in highly space-constrained designs may be required. Through-board vias create a matrix of vias on the board backside, limiting its use for traces and components. These vias can also disrupt the smooth layout of bus runs on internal board layers or limit their placement.

With the ever increasing demand for more compact systems and higher density layouts, three more advanced methods of via connections are being used, the blind via, the buried via, and the micro via. Figure 13 shows an example of these via types used in conjunction with a BGA. Blind vias connect one side of the board to some inner layers, but do not run completely through to the other side. Buried vias connect internal board layers but do not extend to the exterior of the board.

Micro vias are very small vias (4 μm is typical) and can be used for via in pad layouts. This can significantly reduce via density, increase routing options on the board, and conserve space. Laser technology is often used to drill micro vias. Lasers drill micro vias through a 4 millimeter thick dielectric layer, allowing connection to the first internal layer of the board. Two 4 millimeter layers can be drilled with a laser, allowing connection from the surface to the second board layer.

These three via types are more costly than through-board vias from a manufacturing standpoint. However, there are two significant advantages over through-board vias; the elimination of backside vias frees that layer for component placement, and some internal layers and the backside are freed up for traces and uninterrupted bus runs.

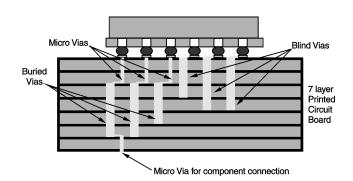
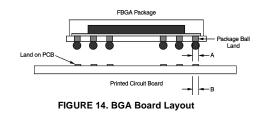


FIGURE 13. Multi Layer Board with BGA Connections to Micro Vias, Buried Vias and Blind Vias

AN-5026

BGA Board Design

To achieve maximum reliability, the design of the PCB on which the BGA is mounted should be considered. In particular, the diameter of package lands and board lands are very important. The actual sizes of these dimensions are key factors, but their ratio is also of critical importance. Figure 14 shows a BGA Board Layout with the optimized ratio equalizes stresses, reducing the chances of a stress cracked solder ball, which will lead to premature system failure. Ratios other than 1 to 1 will lead to unequal distribution of stress loads. For example, solder lands that are larger than the package lands will place a greater amount of stress on the ball at the package land to ball interface.



A = Land diameter on package

B = Land diameter on printed circuit board

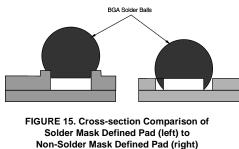
Ratio A/B = 1 for best case reliability

In practice optimum land diameters are as follows:

Solder Mask defined pads: 0.375mm

Non-Solder Mask defined pads: 0.350mm

Experience has shown that solder lands can be either solder mask defined, or non-solder mask defined. However, non-solder mask defined designs provide additional ball-to-land contact area, making them the favored option. The additional contact area is created from the solder ball to pad side connection made during the soldering process. As shown in Figure 15 this creates an improved mechanical connection.



with BGA Solder Ball Connections

BGA Mounting Process

Replacing leaded packages with BGA's offers several board assembly advantages:

- 1. Improved device planarity
- 2. No chance to bend leads
- 3. Greater pad to pad spacing

With no chance to bend or deform leads, BGA products offer PCB manufacturers a significant yield improvement over similar lead count fine-pitch surface mount devices. Another important feature of BGA products is their ability to self-align over the PCB solder lands.

This feature is caused by the surface tension of the solder balls pulling the BGA over the pads.

The use of solder paste is recommended for mounting BGA devices, although it is possible to omit the paste, and only use a flux. The advantages of using paste are:

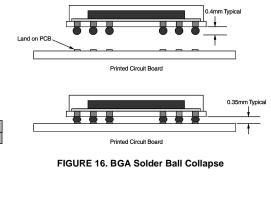
- 1. Paste acts as a flux, and aids wetting of the solder ball to the PCB land.
- Paste, being sticky, helps hold the component in place during reflow.
- Paste helps to overcome any minor variations in planarity of the solder balls.
- Paste contributes to the final volume of solder in the joint, and thus allows this volume to be varied to give an optimum joint.

No-clean type pastes are recommended, due to difficulty in cleaning under the mounted component.

In order to produce the optimum solder joint, it is important to understand the amount of collapse of the solder balls, and the overall shape of the joint. These are a function of:

- 1. The diameter of the BGA solder ball vias.
- 2. The volume and type of solder paste screened onto the PCB.
- 3. The diameter of the PCB land.
- 4. The board assembly re-flow conditions.
- 5. The weight of the package.

As shown in Figure 16, the original ball height on the package is 0.40mm. The ball height typically drops to 0.35mm after the package is mounted.

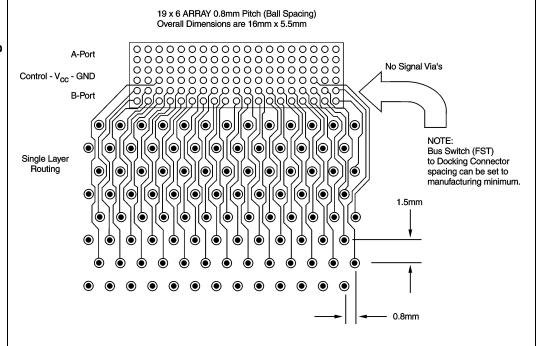


BGA Testing During the prototype and engineering debug phase it may Each of the methods offers advantages and disadvanbe necessary to access IC signals for testing purposes. tages. The prototype socket gives the designer the ability to test multiple devices in the socketed connection. The via Several options exist depending on the specific needs of fan-out method, as shown in Figure 17, incorporates a the system being developed. mounted BGA routed through an array of vias for signal 1. Prototype socket for the BGA accessibility. 2. Via fanout 3. PCB solder mask defined lands With form factor boards large via arrays remove all the board real estate advantage gained with the BGA packaging. Limited I/O access can still be gained using test points like those shown in Figure 18. Minimum Size Via Defined Pattern for Prototype Testing • 19 x 6 ARRAY 0.8mm pitch with package dimensions of 16.0mm x 5.5mm Overall dimensions (including TestVia's) 20.1mm x 8.8mm • 22mil vias, 15mil holes; 6mil line and space PCB rules O CONTROL GND ♥ v_{cc} Data/GND O Data/V_{CC} **O NO CONNECT** GND/NO CONNECT 🔵 Data **O**Via Location FIGURE 17. Via Fan-out for Prototype Testing Solder Mask Defined Land Pattern for In-System Testing • 19 x 6 ARRAY 0.8mm pitch Package Dimensions are 16.0mm x 5.5mm Overall Dimensions are 18.0mm x 7.5mm (Including Land Test Patterns) • 0.15mm (6 mil) Line/Space PCB rules 0.6mm 0.4mm Test Pattern Dimensions FIGURE 18. BGA In-System Testing

AN-5026

Notebook Docking Application

Routing the BGA into the hole pattern created by a typical 0.8mm docking connector can be achieved on a single PCB signal layer. By limiting the signal routing to a single layer, few if any vias are needed for the BGA. Eliminating all datapath vias allows for greater levels of backside usability and backside component placement.



40 signals routed on a single PCB layer

FIGURE 19. BGA Docking Application

Conclusion

FBGA's offer dramatic new levels of PCB layout and design possibilities. BGA's offer space savings of 60% or more vs. TSSOP and greater than 37% over comparable TVSOP and QVSOP packaging. By understanding how to effectively use these new packages, PCB and system designers can create electronic systems with greater component density, miniaturization and functionality. An additional benefit is system manufacturing with less re-work and more reli-

ability. Continued innovations and cost reductions in PCB manufacturing technology will usher in advances in PCB design and further the usability and cost effectiveness of BGA's. With BGA packages already on par with leaded packages in cost per bit for large-scale designs, and the continued drive toward system size reduction, FBGA's of all types are the wave of the future and will soon be everywhere.

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC